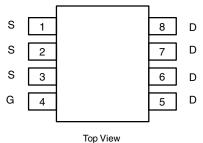




P-Channel 150-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)		
- 150	0.295 at V _{GS} = - 10 V	- 8.9 ^c	23.2 nC		
- 150	0.315 at V _{GS} = - 6 V	- 8.6 ^c	23.2 110		

SO-8



Ordering Information: Si4455DY-T1-E3 (Lead (Pb)-free) Si4455DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

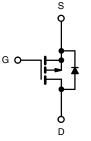
- TrenchFET® Power MOSFET
- 100% R_q and UIS Tested
- Material categorization: For definitions of compliance please see www.vishav.com/doc?99912



HALOGEN FREE

APPLICATIONS

- · Active Clamp in Intermediate DC/ **DC** Power Supplies
- · H-Bridge High Side Switch for Lighting Application



P-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 150	V
Gate-Source Voltage		V _{GS}	± 20	
	T _C = 25 °C		- 2.8	
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C		- 2.3	
Continuous Diairi Curient (1) = 150 °C)	T _A = 25 °C	I _D	- 2 ^{a, b}	
	T _A = 70 °C		- 1.6 ^{a, b}	Α .
Pulsed Drain Current	I _{DM}	- 15	A	
Continuous Source-Drain Diode Current	T _C = 25 °C	I-	- 4.9	
Continuous Source-Drain Diode Current	T _A = 25 °C	- I _S	- 2.5 ^{a, b}	
Avalanche Current	L = 0.1 mH	I _{AS}	- 15	
Single-Pulse Avalanche Energy	L = 0.1 mn	E _{AS}	11.25	mJ
	T _C = 25 °C		5.9	
Maximum Dawar Dissination	T _C = 70 °C	ь Г	3.8	w
Maximum Power Dissipation	T _A = 25 °C	P _D	3.1 ^{a, b}	- vv
	T _A = 70 °C		2 ^{a, b}	
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 55 to 150	°C	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Based on T_C = 25 °C.

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, b}	t ≤ 10 s	R _{thJA}	33	40	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	17	21	C/VV	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. Maximum under steady state conditions is 80 °C/W.

Document Number: 68631 S13-1371-Rev. C, 24-Jun-13 For technical questions, contact: pmostechsupport@vishav.com

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static			l		l	l	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, I}_{D} = -250 \mu\text{A}$	- 150			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050A		- 165		1400	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		- 6.6		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \mu A$	- 2		- 4	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Oata Waltana Busin Oamani	I _{DSS}	V _{DS} = - 150 V, V _{GS} = 0 V V _{DS} = - 150 V, V _{GS} = 0 V, T _J = 55 °C			- 1	μΑ	
Zero Gate Voltage Drain Current					- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 8			Α	
	_	V _{GS} = - 10 V, I _D = - 4 A		0.245	0.295		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -6 \text{ V}, I_D = -3 \text{ A}$		0.260	0.315	5 Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = 4 A		12		S	
Dynamic ^b							
Input Capacitance	C _{iss}			1190			
Output Capacitance	C _{oss}	$V_{DS} = -50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		61		pF	
Reverse Transfer Capacitance	C _{rss}			42			
Tatal Cata Chausa	Q _g	$V_{DS} = -75 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -3 \text{ A}$		27.5	42	42 35 nC	
Total Gate Charge				23.2	35		
Gate-Source Charge	Q _{gs}	$V_{DS} = -75 \text{ V}, V_{GS} = -6 \text{ V}, I_{D} = -3 \text{ A}$		5.4			
Gate-Drain Charge	Q_{gd}			8.4			
Gate Resistance	R _g	f = 1 MHz		6.1	9.2	Ω	
Turn-On Delay Time	t _{d(on)}			20	30		
Rise Time	t _r	V_{DD} = - 75 V, R_L = 25 Ω		95	145		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 3 A, V_{GEN} = - 6 V, R_g = 1 Ω		38	60]	
Fall Time	t _f			34	51	no	
Turn-On Delay Time	t _{d(on)}			11	18	ns	
Rise Time	t _r	V_{DD} = - 75 V, R_L = 25 Ω		28	42		
Turn-Off DelayTime	t _{d(off)}	$I_D\cong$ - 3 A, $V_{GEN}=$ - 10 V, $R_g=$ 1 Ω		52	78		
Fall Time	t _f			35	53		
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 13	^	
Pulse Diode Forward Current ^a	I _{SM}				- 15	Α	
Body Diode Voltage	V _{SD}	I _S = - 3 A		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			65	90	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	$\frac{Q_{rr}}{t_a}$ $I_F = -4 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 \text{ °C}$		180	270	nC	
Reverse Recovery Fall Time	t _a			45		ns	
Reverse Recovery Rise Time	t _b			20			

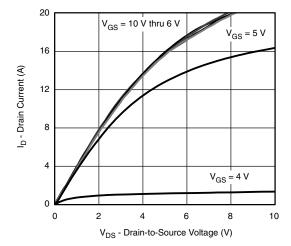
Notes:

- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

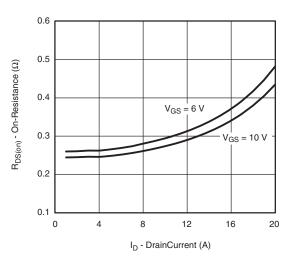
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



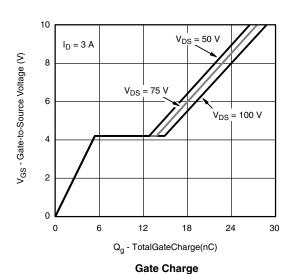
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

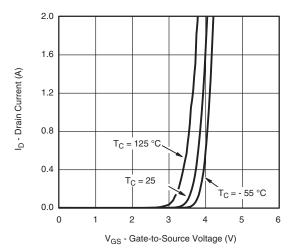


Output Characteristics

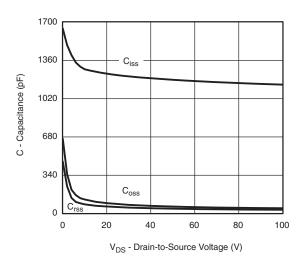


On-Resistance vs. Drain Current and Gate Voltage

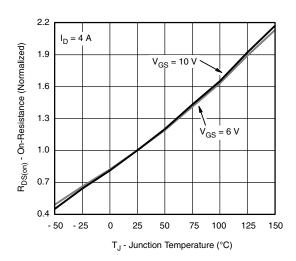




Transfer Characteristics



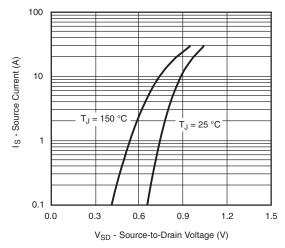
Capacitance



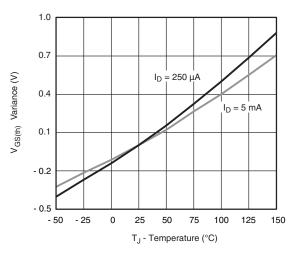
On-Resistance vs. Junction Temperature

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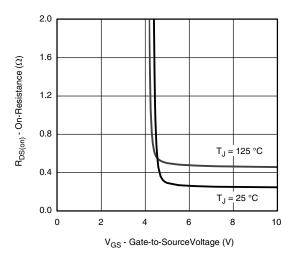
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



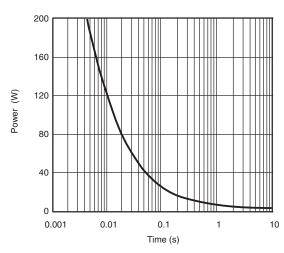
Source-Drain Diode Forward Voltage



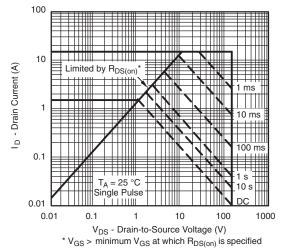
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



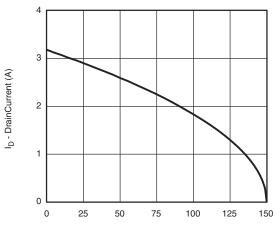
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient

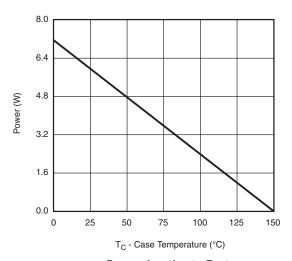


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

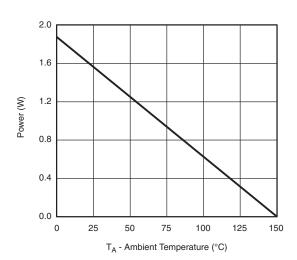


T_C - Case Temperature (°C)

Current Derating*







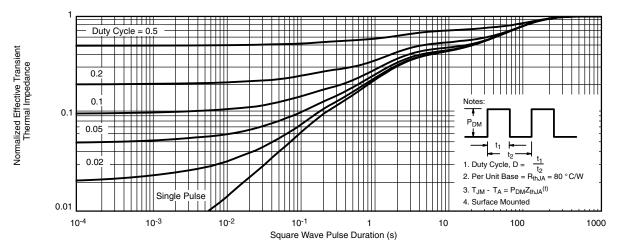
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heats inking is used. It is used to determine the current rating, when this rating falls below the package limit.

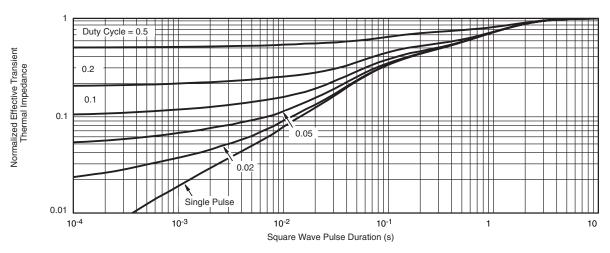
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIMETERS INCHES			HES		
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I. 11-Sep-06						

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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